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PATENT

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IN THE U.S. PATENT AND TRADEMARK OFFICE

Applicant: MUELLER, Juergen Rolf Conf.:

Int'l. Appl. No.: PCT/EP99/10142

Appl. No.: New Group:

Filed: June 21, 2001 Examiner:

For: SCANNING MICROSCOPIC METHOD HAVING HIGH AXIAL RESOLUTION

#5/A
 B. Mayo
 R. Talley

PRELIMINARY AMENDMENT

BOX PATENT APPLICATION

Assistant Commissioner for Patents
Washington, DC 20231

June 21, 2001

Sir:

The following Preliminary Amendments and Remarks are respectfully submitted in connection with the above-identified application.

AMENDMENTS

IN THE SPECIFICATION:

Please amend the specification as follows:

Before line 1, insert --This application is the national phase under 35 U.S.C. § 371 of PCT International Application No. PCT/EP99/10142 which has an International filing date of December 20, 1999, which designated the United States of America and was published in English.--

A1

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